Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/023,866	OHNO ET AL.
Examiner	Art Unit

Clyde H. Jones III

2611

SEARCHED						
Class	Subclass	Date	Examiner			
725	133,39,34	2/11/2006	cı			
348	734	2/11/2006	Cl			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Hai Tran -726-2611	2/10/2006	cì	
Son Huynh - 725- 2611 - reference	2/10/2006	CJ	